

PTO-1449

U.S. Dept. of Commerce - Patent &amp; Trademark Office

**INFORMATION DISCLOSURE STATEMENT BY APPLICANT****LIST OF REFERENCES CITED BY APPLICANT**

Applicant: Verma et al  
 Serial No.: To be assigned  
 Filing Date: August 21, 2003

Case No.: J6852(C)  
 UNUS No.: 03-R223-EDG  
 Group: Unknown 1616

**U.S. PATENT DOCUMENTS**

EXAM. INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
CA	2002/0037261	03/28/02	Lapidot et al.			
DA	3,083,113	03/26/63	Korf et al.			
EM	4,923,518	05/08/90	Brand et al.			
GA	5,914,101	06/22/99	Tapley et al.			
GA	5,916,544	06/29/99	Liu et al.			
EA	6,146,617	11/14/00	Kurz et al.			
EA	6,153,177	11/28/00	Bartolone et al.			
EA	6,162,836	12/19/00	Kato			
EA	6,238,650	03/28/02	Lapidot et al.			

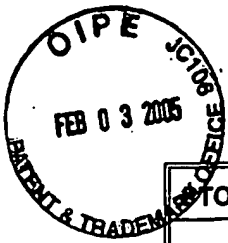
**FOREIGN PATENT DOCUMENTS**

EXAM. INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO
GA	1 167 462	02 Jan. 02	EP			
GA	03/025071	27 Mar. 03	WO			

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)**

EA	Kruger, F.W.H. et al., A DSC Study of Curative Interactions, <i>Journal of Appl. Polymer Science</i> , 42:2643-2649 (1991).
Not present	<del>Laufer et al., Objective Measurement and Self-Assessment of Skin-Care Treatments, <i>Cosmetics and Toiletries Magazine</i>, Vol. 111, pp. 92-96, June 1996.</del>
	08/01/05

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



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**INFORMATION DISCLOSURE STATEMENT BY APPLICANT****LIST OF REFERENCES CITED BY APPLICANT**

Applicant: Yuan, et al.  
Serial No.: 10/645,576  
Filing Date: August 21, 2003

Case No.: J6852(C)  
UNUS No.: 03-R223-EDG  
Group: 1616

**U.S. PATENT DOCUMENTS**

EXAM. INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
SW	5 441 726	15 Aug. 95	Muhammed, et al.			
SW	5 968 529	19 Oct. 99	Nishizawa, et al.			
SW	5 980 871	09 Nov. 99	Lukenbach, et al.			

**FOREIGN PATENT DOCUMENTS**

EXAM. INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	<u>TRANSLATION</u> YES NO
SW	1 230 907	14 Aug. 02	EP			
SW	03/072077	04 Sep. 03	WO			

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)**

SW	PCT International Search Report, PCT/EP2004/008668 mailed on November 11, 2004, 3 pp.
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

*Emt*

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